## Search Notes Application/Control No. Applicant(s)/Patent Under Reexamination CHANG, YI-HUI Examiner Mike Qi Art Unit 2871

SEARCHED						
Class	Subclass	Date	Examiner			
349	61, 62, 64	7/29/08	MQ			
345	82,46, 102	7/29/08	MQ			

SEARCH NOTES				
Search Notes	Date	Examiner		
Searched in USPG-	7/29/08	MQ		
PUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TDB.				
Interference searched.	7/29/08	MQ		

INTERFERENCE SEARCH						
Class	Subclass	Date	Examiner			
349	61, 62, 64	7/29/08	MQ			
345	82,46, 102	7/29/08	MQ			

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